

**Search Notes**

Application/Control No.

10/624,689

Examiner

Mark A. Chapman

Applicant(s)/Patent under  
Reexamination

KOBAYASHI ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	124	6/10/2005	MC
	97		
	48		
	56		
369	272.1		
	273		
428	412		
	480		
	483		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	6/10/2005	MC
reviewed related application		